# LASER INTERFEROMETER GRAVITATIONAL WAVE OBSERVATORY LIGO

# COMPONENT SPECIFICATION

E0900246 -V4- D **Drawing No** Rev. Group

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# Coated Substrate, ALIGO SIGNAL RECYCLING MIRROR

			APPROVALS		
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Name: SRM, F-SRM

## **Applicable Documents**

D0901174-v4-D Signal Recycling Mirror Substrate (Substrate Drawing - unfolded) D0901175-v4-D Folded Signal Recycling Mirror Substrate (Substrate Drawing - folded)

E0900089-v4-D Substrate, ALIGO Signal Recycling Mirror (SRM, Substrate Specification - unfolded) E0900090-v4-D Substrate, ALIGO Signal Recycling Mirror (F-SRM, Substrate Specification - folded)

E080028-A Mirror Blank Material, AdLIGO Recycling Mirror 1 (RM1, Blank Specification)

## **Physical Configuration**

Fabricated from: D0901174-v4-D Signal Recycling Mirror Substrate, and

D0901175-v4-D Folded Signal Recycling Mirror Substrate

## General to Surfaces 1 and 2

To Bevel **Coating Area** 

**Coating Deposition** 

Method

Ion Beam Sputtering

To comply with Advanced LIGO Component Specification E0900089-v4-D and **Surface Quality** 

E0900090-v4-D, Substrate, ALIGO Signal Recycling Mirror (SRM and F-SRM) (Page

2): "Scratches and Point Defects".

Figure Change **Before/After Coating**  Coating uniformity and stress for the coating process shall not change the saggita more than 5 nm over the central 35 mm diameter aperture, and more than 0.4 nm over the

central 10 mm diameter aperture (ROC > 30 Km).

Also, coating process shall not add surface figure Zernike terms higher than the second order with amplitude > 0.5 nm over the central 35 mm diameter and more than 0.3 nm

over the central 10 mm.

Witness Sample **Durability Testing** 

On a representative witness piece per run:

1. Coating to resist adhesion test per MIL-C-48497A 4.5.3.1 Adhesion (snap

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tape).

- Coating to resist humidity test per MIL-C-48497A 4.5.3.2 Humidity (120F and 95% to 100% relative humidity for 24 hr), combined with before/after spectrometer scan, marking the specimen to ensure the same area is scanned. The scans should be done over the entire spectrometer range, with minimum range covered of 500-1400 nm. There should be no measurable spectral shift.
- Coating to resist abrasion test per MIL-C-48497A 4.5.3.3 Moderate Abrasion (cheese cloth rub)

## **Surface 1: HR coating**

### Note: Arrow on the optic barrel points in the direction of Surface 1, the Highly Reflective (HR) surface!

**Coating type** Highly Reflective at 1064 nm

Angle of Incidence (AOI) SRM: NORMAL (0.00 degrees)

F-SRM: NORMAL (0.00 degrees)

Transmission at 1064 nm  $0.20 \pm 0.01$  at the designed AOI

Transmission in the 670 - 900 nm band

Not specified, but preferably as high as possible at normal incidence. Vendor will provide coating design and transmission data for this range (see pages 3-4 for

Additional Deliverables).

Transmission at 532 nm Not specified, but preferably as high as possible at normal incidence. Vendor will

provide coating design and transmission data for this wavelength (see pages 3-4 for

Additional Deliverables).

**Surface Electric Field** Zero (Goal), < 0.01V/m (Requirement)

< 0.5 ppm (Goal), <1ppm (Requirement) Absorption at 1064 nm

**Optical Performance** Uniformity

The specified single surface reflectance at the specified wavelength and angle of

incidence must be maintained over at least 30 mm diameter aperture.

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**Surface 2: AR coating** 

Coating type Antireflective at 1064 nm

**Angle of Incidence** 

(AOI)

SRM: 1.45 degrees on the vacuum side, S polarization

F-SRM: 1.45 degrees on the vacuum side, S polarization

The P-polarized beam will hit the HR surface at normal incidence, but because the optic is vertically wedged, it will exit the AR surface at the above AOI, and will therefore

have S-polarization.

**Reflection at 1064 nm** <50 ppm (Goal), <100 ppm (Requirement) at the designed AOI

Reflection in the

670 – 900 nm band Not specified – but preferably low at the design AOI

**Reflection at 532 nm** Not specified – but preferably low at the design AOI

**Absorption at 1064 nm** < 3 ppm

**Optical Performance** 

Uniformity

The specified single surface reflectance at the specified wavelength and angle of

incidence must be maintained over at least 30 mm diameter aperture.

## **ADDITIONAL DELIVERABLES:**

Coating manufacturer to provide:

#### 1. 1" WITNESS SAMPLES for Surfaces 1 and 2:

Three 1-inch fused silica witness plates (provided by the vendor) **from each coating run**, which undergo the same coating process as the main optic: HR on one side and AR on the other side. The witness pieces should be superpolished on the HR side and nominally polished and wedged at 0.5 deg on the AR side. The 1-inch coated witness plates should be representative for the individual coating runs.

#### 2. LAYER THICKNESS INFORMATION

For all layers in the design, measured thickness data from the deposition from each run, designed thickness, and measured indices of refraction over the entire dispersion range (including at 1064 nm) for both coating materials (based on individual layers).

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#### 3. SPECTRAL SCANS – Surfaces 1 and 2

On a representative 1-inch witness sample for each run, the coating manufacturer will provide the following data:

a. Spectrophotometer graphs of the Reflectance and Transmittance of each surface (Surface 1 – HR coating and Surface 2 - AR coating) at the specified angles of incidence, over the over the entire spectrometer range, with minimum range covered of 500-1400 nm. The scans will be taken before the sample is coated, between the Surface 1 and Surface 2 coating and after the coating is completed. All spectrometer data to be provided in Excel spreadsheet format, with columnar data in increments of approximately 1 nm.

#### 4. SURFACE DEFECT ANALYSIS - Scratches and point defects:

#### a. Hand Sketch:

- i. The surface is examined visually by two observers independently. The examination is done against a dark background using a fiber optic illuminator system of at least 200 W total power. A 100% inspection of the surface is carried out. Pits and scratches down to 2 micrometers in width can be detected using this method of inspection. Any scratches or sleeks that are detected will be measured using a calibrated eyepiece.
- **ii.** Farther inspection will be done with a minimum 6X eyeglass using the same illumination conditions, again with two observers. Sleeks down to 0.5 micrometers wide can be detected using this method. The surface will be scanned along one or two chords from center to edge, then at ten positions around the edge, and ten to fifteen positions near the center.
- b. **Digital Images:** An inspection is then carried out with a dark or bright field microscope, with 5X objective at four positions at each of the following locations:
  - i. Within 5 mm of the center of the surface (HR and AR sides).
  - ii. Equally spaced along the circumference of a centered, 10 mm diameter circle (HR and AR sides).

#### 5. DURABILITY TEST DATA & SAMPLES:

All samples from the durability tests and data, including spectrophotometer scans of the representative coating on each side in an Excel spreadsheet.

### Coating Specifications for the 2" surrogates: SRM-s and F-SRM-s

#### **Background:**

The **2" surrogates** are curve/plano optics with the same radii of curvature as the main optic, serialized as SRM-s-01 to SRM-s-06, and F-SRM-s-01 to F-SRM-s-03.

They will be provided to the coating vendor by the University of Florida, and are polished by the same polishing vendor and to the same specifications as the corresponding main optic (SRM and F-SRM), over the central 30 mm diameter.

The substrates specifications of these samples are listed on page 4 of E0900089-v4-D and E0900090-v4-D.

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### **Coatings Specifications:**

The 2" surrogates SRM-s and F-SRM-s will be coated for the same angles of incidence, polarization and using the same HR and AR coating design as for the main optics SRM and F-SRM (for all wavelengths listed in this specification), but with the following coating types:

2 pcs SRM-s and 1 pc F-SRM-s will have AR coatings on both surfaces.

2 pcs SRM-s and 1 pc F-SRM-s will have HR coating on the curved surface, and AR coating on the flat surface.

### In addition, the following parts will have a different HR coating design:

<u>2 pcs SRM-s will have HR coating on the curved surface with transmission of 0.35 +/- 0.02 at 1064 nm, and AR coating on the flat surface at 1064 nm.</u>

#### If/When possible, the coating should be done in the same coating runs as the main optic.

Their purpose is also to allow early or supplementary metrology be performed on these optics rather than on the main optic. They should be representative for the main optic in terms of absorption, surface figure, surface errors and optical performance (reflection of AR surface).

In addition, these optics will be deployed in the interferometer in Advanced LIGO for initial alignment, and also used in the early operation stage of the interferometer. For this reason, they are called "SURROGATES".

The arrow on the barrel of the optic points to the high reflective surface (for the HR/AR coated parts), or the curved surface, perpendicular to the optic axis (for the AR/AR).

#### **Deliverables:**

Spectrophotometer graphs of the Reflectance and Transmittance of each surface as explained at point 3.a. on page 4 of this specification.